

<b>Notice of References Cited</b>				Application/Control No. <i>10/067,362</i> 08749,671		Applicant(s)/Patent Under Reexamination SCHENKEL ET AL.			
				Examiner Peter S Stecher		Art Unit 2755	Page 1 of 1		
<b>U.S. PATENT DOCUMENTS</b>									
*	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	DOCUMENT SOURCE --			
<input checked="" type="checkbox"/>	A 5608659	May. 1997	Lin et al	364	554	<input type="checkbox"/>	<input type="checkbox"/>		
<input checked="" type="checkbox"/>	B 5430729	Jul. 1995	Rahnerma	270	94.1	<input type="checkbox"/>	<input type="checkbox"/>		
<input checked="" type="checkbox"/>	C 5182750	Jan. 1993	Bales et al	370	110.1	<input type="checkbox"/>	<input type="checkbox"/>		
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<b>FOREIGN PATENT DOCUMENTS</b>									
*	DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUBCLASS	DOCUMENT SOURCE --		
<input checked="" type="checkbox"/>	N WO 94/19889	Sep. 1994	PCT WO	Bright et al	1041	1041	<input type="checkbox"/>	<input type="checkbox"/>	
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Notice of References Cited

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02/07/04

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/067,362 SCHENKEL ET AL.	
		Examiner	Art Unit	Page 1 of 1 Larry D Donaghue

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,793,975	08-1998	Zeldin, Paul	709/224
	B	US-5,751,966	05-1998	Dauerer et al.	709/224
	C	US-5,737,319	04-1998	Croslin et al.	370/255
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
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